


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590779	<b>Applicant(s)/Patent Under Reexamination</b>  KAWANO ET AL.
	<b>Examiner</b>  H. T Le	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
428	403,404,405,406	6/21/08	HL
501	134,137,138,139	12/29/08	HL
427	215,226,372.2	10/22/09	HL

SEARCH NOTES		
Search Notes	Date	Examiner
WEST	6/21/08	HL
WEST (updated)	12/29/08	hl
WEST (updated)	8/16/09	hl
WEST (updated)	10/22/09	hl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
427	215,226,372.2	10/22/09	hl
428	403,570	10/22/09	hl
501	134,136,137,138,139	10/22/09	hl

	/H. T. L./ Primary Examiner.Art Unit 1794
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